

SCANWORKS® IJTAG MANUFACTURING

Adding IJTAG to your Non-intrusive Board Test strategy for better test coverage and diagnostics.

OVERVIEW

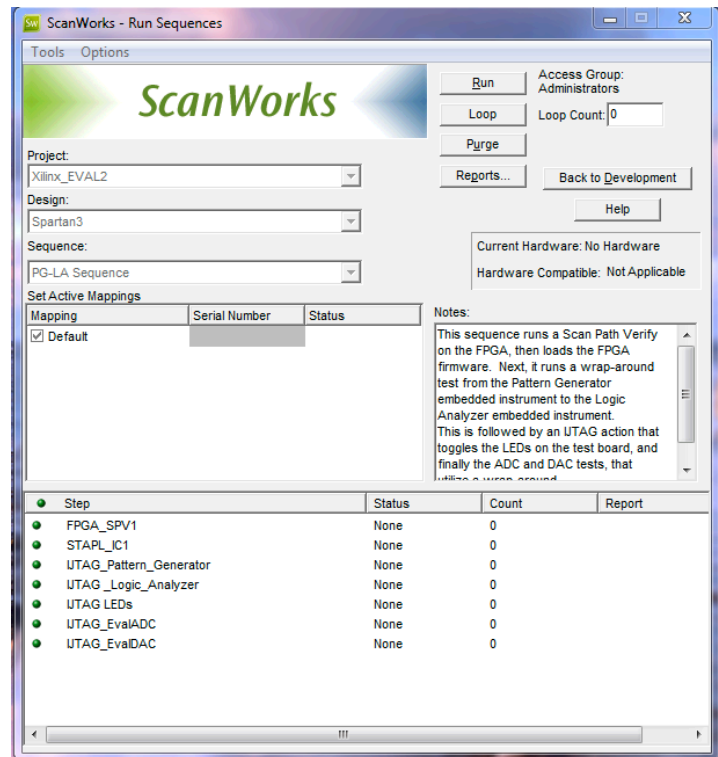
ScanWorks® IJTAG Manufacturing (IJTAG-ML) software enables reuse of your IJTAG test programs in a manufacturing environment just like boundary-scan test. IJTAG-ML supports the unique instrument operations described in IEEE P1687 Procedural Description Language models to control and run embedded instruments. The IJTAG test programs can be integrated into the ScanWorks platform test sequencer for execution and diagnostics.

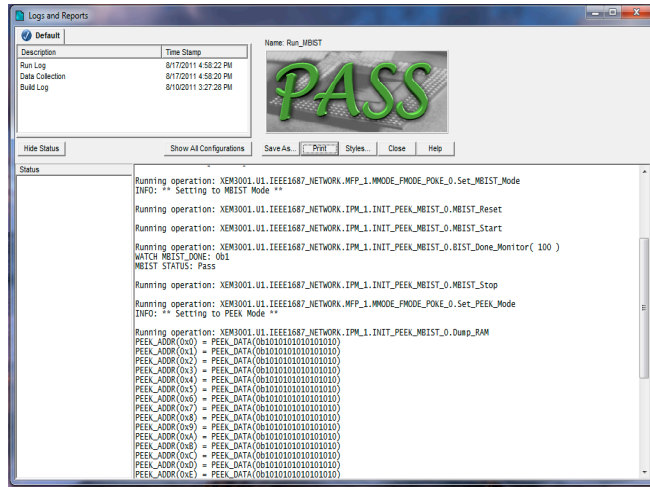
IJTAG TEST PROGRAM EXECUTION

Procedural Description Language (PDL) for IJTAG works hand in hand with the Instrument Connectivity Language (ICL) that was created during the test development process using the IJTAG Development software. The ICL tells the IJTAG-ML where the instruments are located inside the chip from the view point of the JTAG TAP. The PDL engine within the IJTAG-ML executes the IJTAG instructions within your test program on your specific instruments.

IJTAG TEST PROGRAM DIAGNOSTICS

Diagnostics are instrument specific. Within the PDL of each instrument, the diagnostic routines are defined if applicable. Most instruments will include diagnostic routines either built into the PDL or developed during the test development process utilizing the IJTAG development software. The IJTAG development software supports a simple drag and drop development mode or a customized development mode for diagnostic development. The customized development mode is supported by a Tcl (tool command language) interpreter (PDL is based on Tcl) as a standard part of the IJTAG development software.





USER INTERFACE AND APIS

The IJTAG manufacturing software works within the ScanWorks platform sequencer. The user interface allows engineers to apply existing actions and sequences to the unit being tested. Once a sequence is selected, the actions within that sequence are displayed along with their status. The sequencer can handle pre- and post-conditions on step level, iterative looping of steps, input of UUT serial numbers, user notes and more. Standard result reports are easily viewed showing the results of each sequence step with links to

the detailed information for that given step. The same functionality as the Sequencer provides, and more, is available through the ScanWorks APIs, which functions in conjunction with LabVIEW™, LabWindows™, Test Stand, Agilent (HP)-VEE, Visual Basic®, Tcl, Perl, C, C++, C#, allowing the IJTAG tests to be executed and diagnosed from virtually any test executive.

SCANWORKS PLATFORM FOR EMBEDDED INSTRUMENTS

ScanWorks Platform for Embedded Instruments is a seamless software environment to access, run and collect data from any instrument in your chips, circuit boards or systems. The ScanWorks Platform includes products for Boundary-Scan Test (BST), Processor-Controlled Test (PCT), High-Speed I/O (HSIO) Validation, FPGA-Controlled Test (FCT) and IJTAG test.

ASSET CONTACTS:

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